

## HIGH VOLTAGE FAST-SWITCHING NPN POWER TRANSISTOR

### PRELIMINARY DATA

- HIGH VOLTAGE CAPABILITY
- LOW SPREAD OF DYNAMIC PARAMETERS
- MINIMUM LOT-TO-LOT SPREAD FOR RELIABLE OPERATION
- LOW BASE-DRIVE REQUIREMENTS
- VERY HIGH SWITCHING SPEED
- FULLY CHARACTERISED AT 125°C
- HIGH RUGGEDNESS
- INTEGRATED ANTIPARALLEL COLLECTOR-EMITTER DIODE

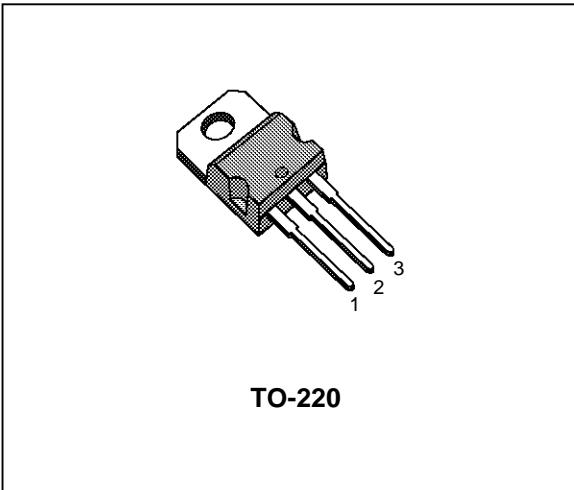
### APPLICATIONS

- ELECTRONIC TRANSFORMERS FOR HALOGEN LAMPS
- ELECTRONIC BALLASTS FOR FLUORESCENT LIGHTING
- SWITCH MODE POWER SUPPLIES

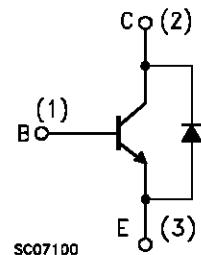
### DESCRIPTION

The BUL58D is manufactured using high voltage Multi Epitaxial Planar technology to enhance switching speeds while maintaining a wide RBSOA.

The BUL series is designed for use in lighting applications and low cost switch-mode power supplies.



### INTERNAL SCHEMATIC DIAGRAM



### ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V <sub>CES</sub>	Collector-Emitter Voltage ( $V_{BE} = 0$ )	800	V
V <sub>CEO</sub>	Collector-Emitter Voltage ( $I_B = 0$ )	450	V
V <sub>EBO</sub>	Emitter-Base Voltage ( $I_C = 0$ )	10	V
I <sub>C</sub>	Collector Current	8	A
I <sub>CM</sub>	Collector Peak Current ( $t_p < 5 \text{ ms}$ )	12	A
I <sub>B</sub>	Base Current	4	A
I <sub>BM</sub>	Base Peak Current ( $t_p < 5 \text{ ms}$ )	8	A
P <sub>tot</sub>	Total Dissipation at $T_c = 25^\circ\text{C}$	75	W
T <sub>stg</sub>	Storage Temperature Range	-65 to 150	°C
T <sub>j</sub>	Max. Operating Junction Temperature	150	°C

# BUL58D

## THERMAL DATA

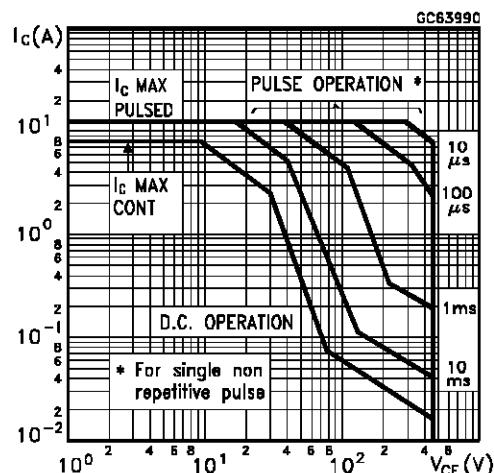
$R_{thj-case}$	Thermal Resistance Junction-Case	Max	1.65	$^{\circ}\text{C}/\text{W}$
$R_{thj-amb}$	Thermal Resistance Junction-Ambient	Max	62.5	$^{\circ}\text{C}/\text{W}$

## ELECTRICAL CHARACTERISTICS ( $T_{case} = 25^{\circ}\text{C}$ unless otherwise specified)

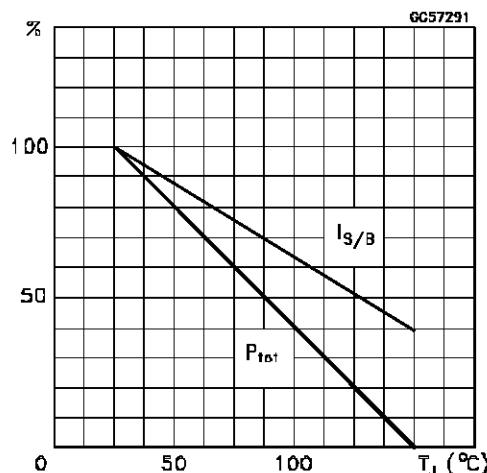
Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$I_{CES}$	Collector Cut-off Current ( $V_{BE} = 0$ )	$V_{CE} = 800 \text{ V}$			200	$\mu\text{A}$
$I_{CEO}$	Collector Cut-off Current ( $I_B = 0$ )	$V_{CE} = 450 \text{ V}$			200	$\mu\text{A}$
$V_{CEO(sus)}$	Collector-Emitter Sustaining Voltage	$I_C = 100 \text{ mA} \quad L = 25 \text{ mH}$	450			V
$V_{EBO}$	Emitter-Base Voltage ( $I_C = 0$ )	$I_E = 10 \text{ mA}$	9			V
$V_{CE(sat)*}$	Collector-Emitter Saturation Voltage	$I_C = 4 \text{ A} \quad I_B = 0.8 \text{ A}$ $I_C = 5 \text{ A} \quad I_B = 1 \text{ A}$			1.5 2	V V
$V_{BE(sat)*}$	Base-Emitter Saturation Voltage	$I_C = 4 \text{ A} \quad I_B = 0.8 \text{ A}$ $I_C = 5 \text{ A} \quad I_B = 1 \text{ A}$			1.3 1.5	V V
$h_{FE}^*$	DC Current Gain	$I_C = 5 \text{ A} \quad V_{CE} = 5 \text{ V}$ $I_C = 500 \text{ mA} \quad V_{CE} = 5 \text{ V}$	5	38		
$t_s$ $t_f$	INDUCTIVE LOAD Storage Time Fall Time	$I_C = 2 \text{ A} \quad I_{B1} = 0.4 \text{ A}$ $V_{BE(off)} = -5 \text{ V} \quad R_{BB} = 0 \Omega$ $V_{CL} = 250 \text{ V} \quad L = 200 \mu\text{H}$		1 90	1.8 180	$\mu\text{s}$ ns
$t_s$ $t_f$	INDUCTIVE LOAD Storage Time Fall Time	$I_C = 2 \text{ A} \quad I_{B1} = 0.4 \text{ A}$ $V_{BE(off)} = -5 \text{ V} \quad R_{BB} = 0 \Omega$ $V_{CL} = 250 \text{ V} \quad L = 200 \mu\text{H}$ $T_j = 125^{\circ}\text{C}$		1.5 180		$\mu\text{s}$ ns
$V_f$	Diode Forward Voltage	$I_C = 3 \text{ A}$			3	V

\* Pulsed: Pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5 %

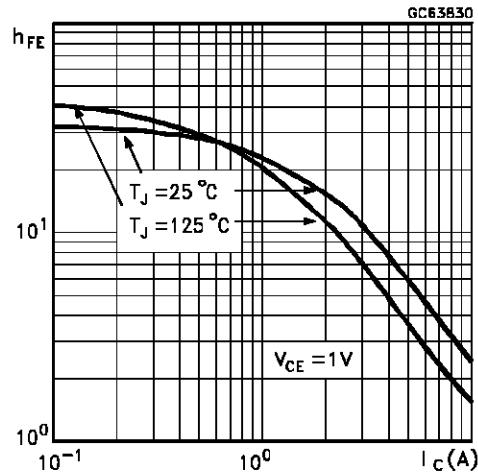
## Safe Operating Areas



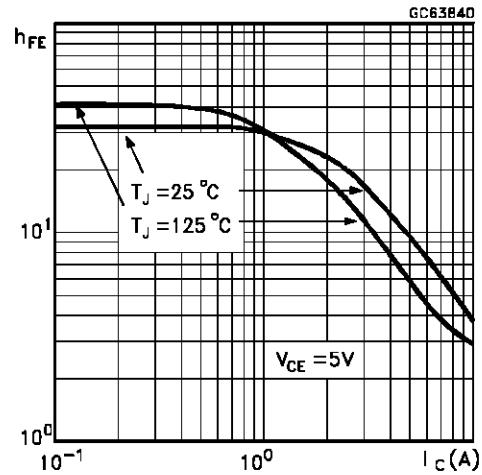
## Derating Curves



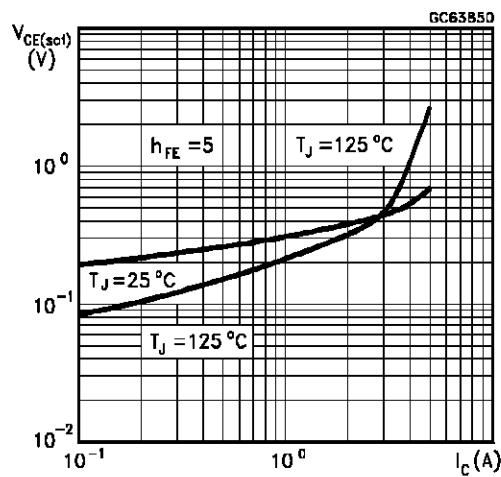
DC Current Gain



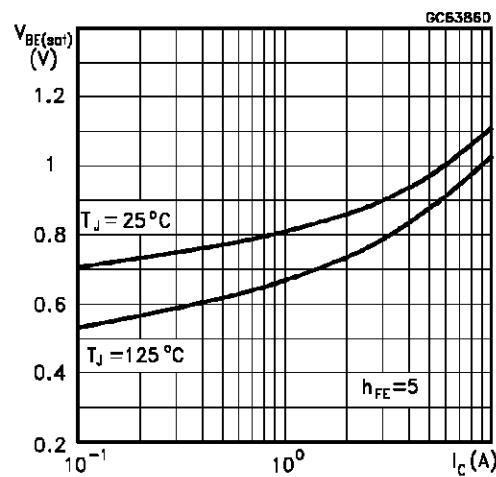
DC Current Gain



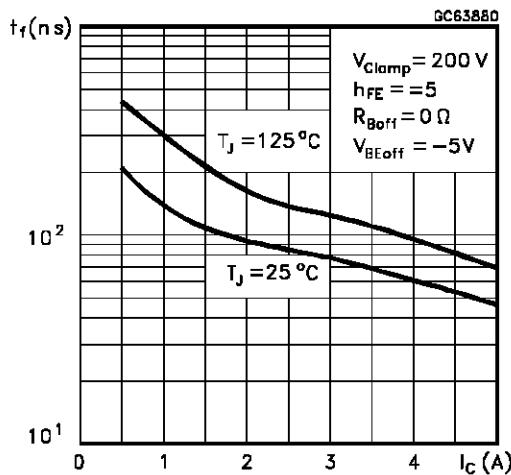
Collector Emitter Saturation Voltage



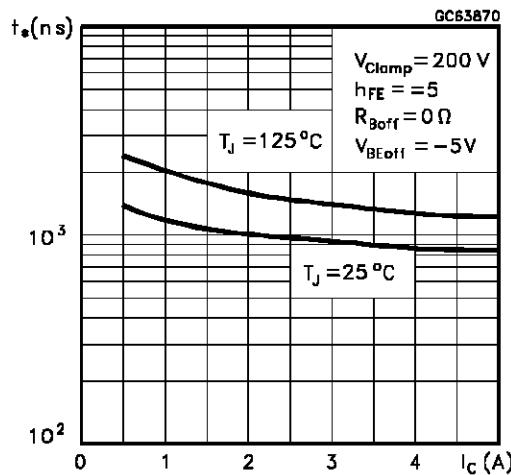
Base Emitter Saturation Voltage



Inductive Fall Time



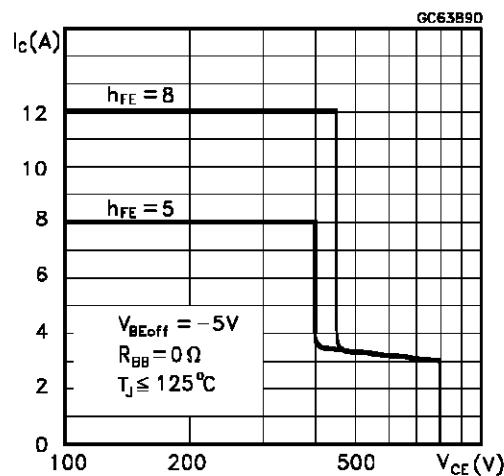
Inductive Storage Time



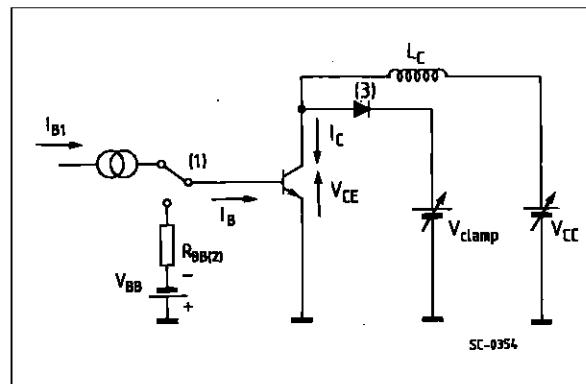
## BUL58D

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### Reverse Biased SOA



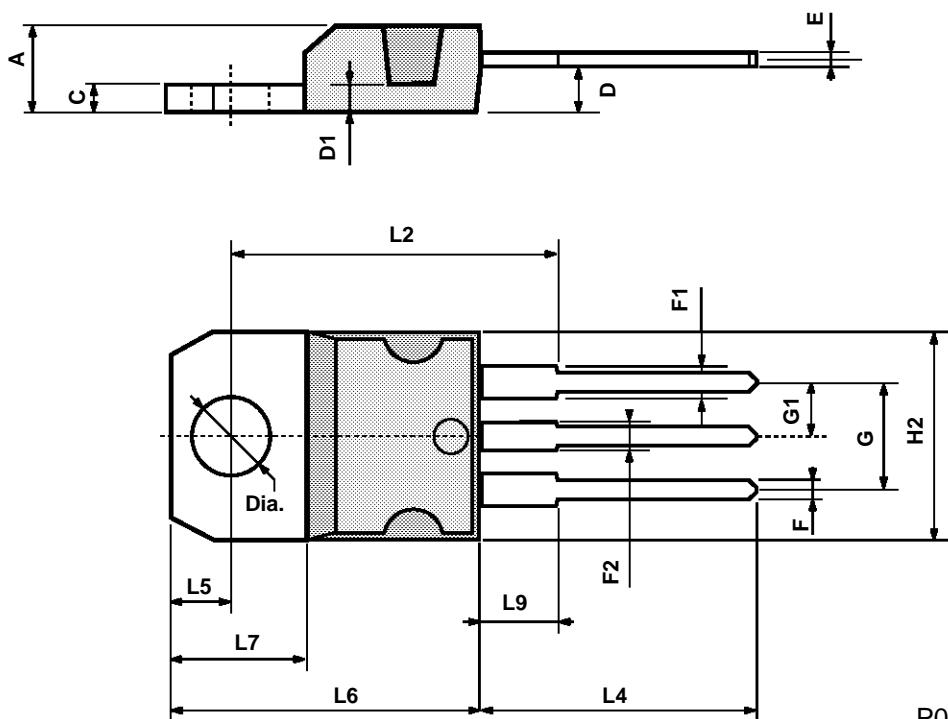
### RBSOA and Inductive Load Switching Test Circuit



- (1) Fast electronic switch
- (2) Non-inductive Resistor
- (3) Fast recovery rectifier

## TO-220 MECHANICAL DATA

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A	4.40		4.60	0.173		0.181
C	1.23		1.32	0.048		0.051
D	2.40		2.72	0.094		0.107
D1		1.27			0.050	
E	0.49		0.70	0.019		0.027
F	0.61		0.88	0.024		0.034
F1	1.14		1.70	0.044		0.067
F2	1.14		1.70	0.044		0.067
G	4.95		5.15	0.194		0.203
G1	2.4		2.7	0.094		0.106
H2	10.0		10.40	0.393		0.409
L2		16.4			0.645	
L4	13.0		14.0	0.511		0.551
L5	2.65		2.95	0.104		0.116
L6	15.25		15.75	0.600		0.620
L7	6.2		6.6	0.244		0.260
L9	3.5		3.93	0.137		0.154
DIA.	3.75		3.85	0.147		0.151



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